



# Experimental Results of Electron Method for Remote Spacecraft Charge Sensing

**Miles Bengtson**  
*Graduate Research Assistant*

**Kieran Wilson**  
*Graduate Research Assistant*

**Hanspeter Schaub**  
*Professor*  
*Glenn L. Murphy Chair of Engineering*

*Applied Space Environments Conference*  
*Los Angeles, CA, May 16, 2019*

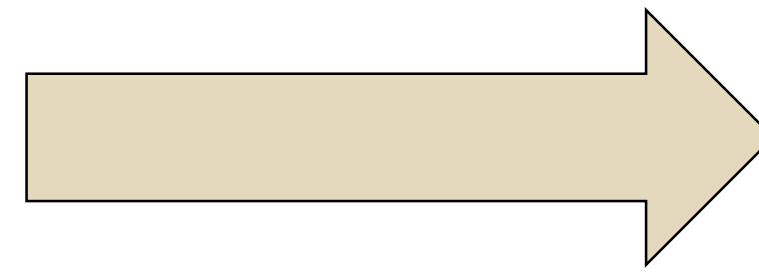


Ann and H. J. Smead Aerospace  
Engineering Sciences Department  
University of Colorado, Boulder

# Motivation for Touchless Sensing

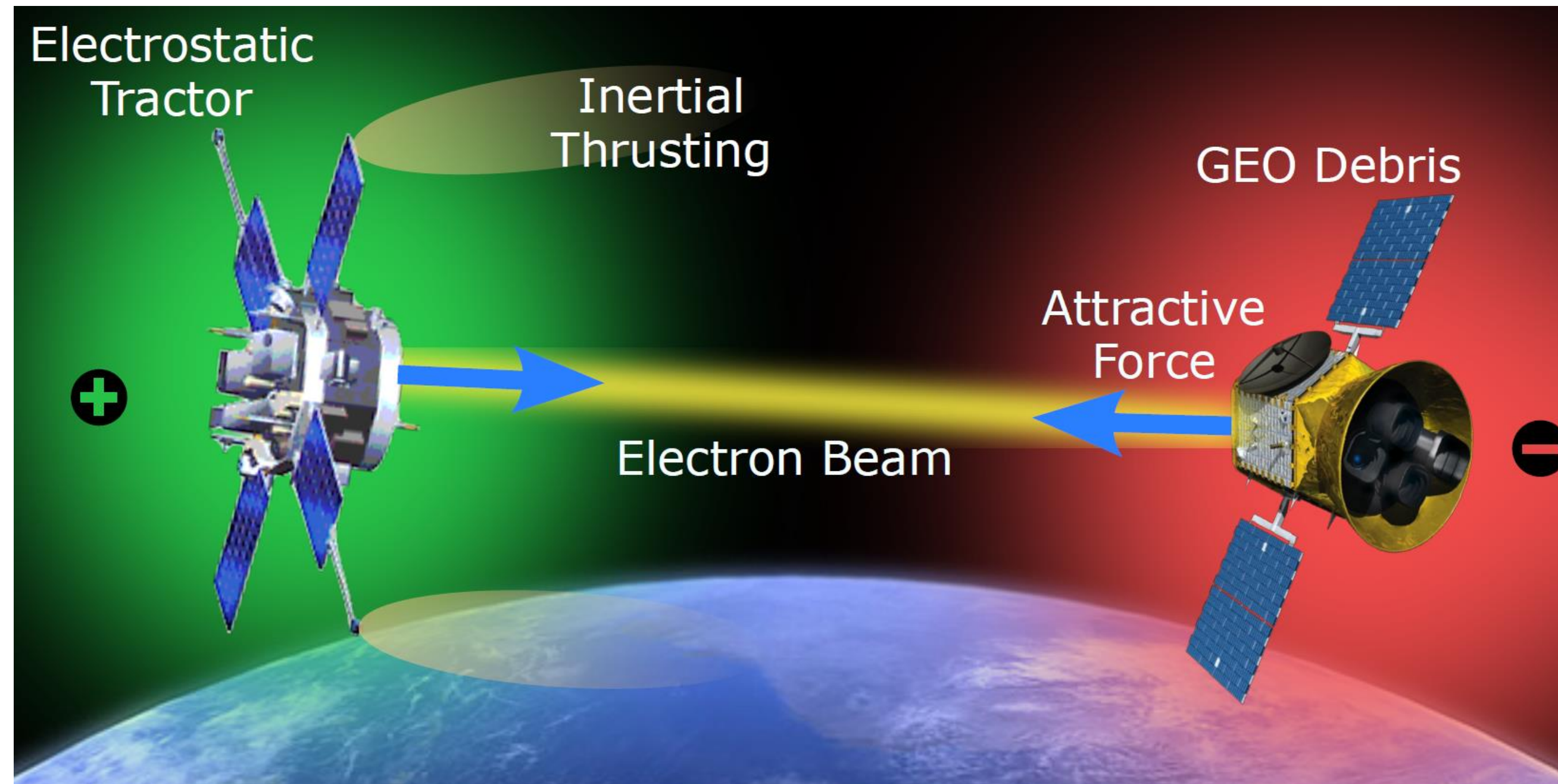
## *Mitigation of unwanted effects*

- On orbit experiments to study:
  - Spacecraft charging
  - Material surface evolution
- ESD prevention during docking/contact operations



## *Enabling new capabilities*

- Electrostatic Tractor
- Detumbling of space debris
- Coulomb formations
- Lunar/asteroid surface characterization
- Material identification for SSA

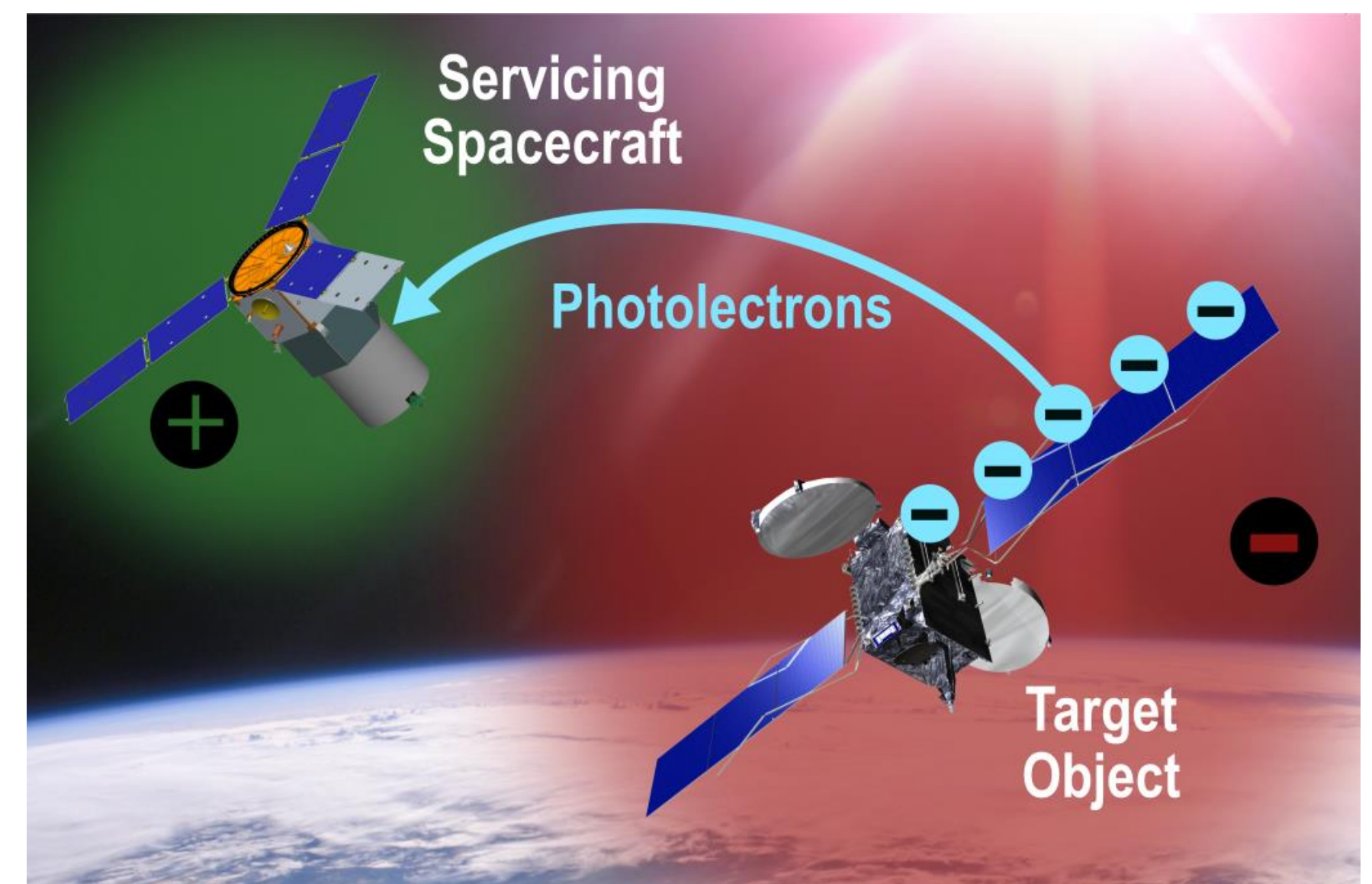
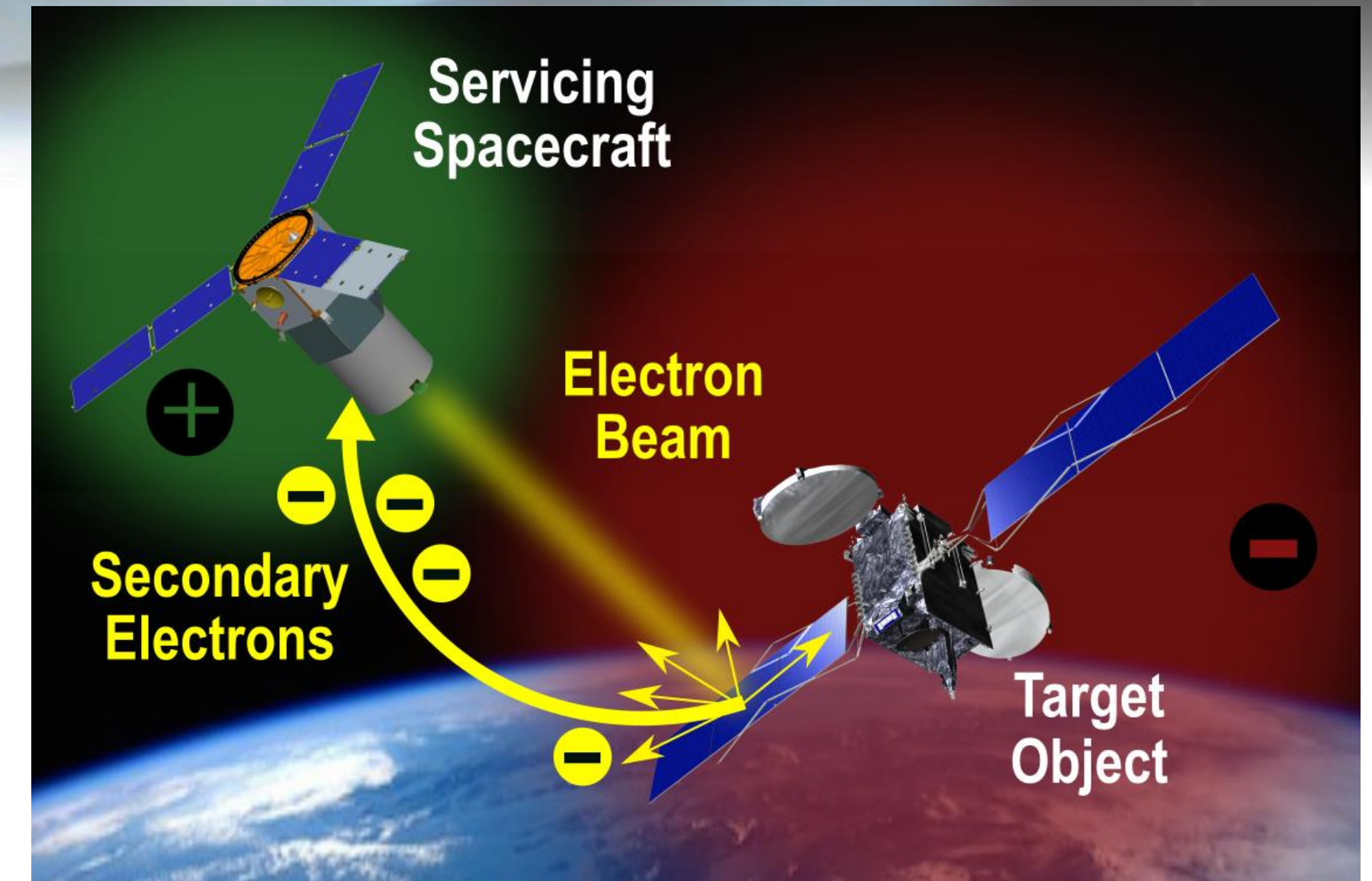


# Concept for Touchless Potential Sensing



## Concept:

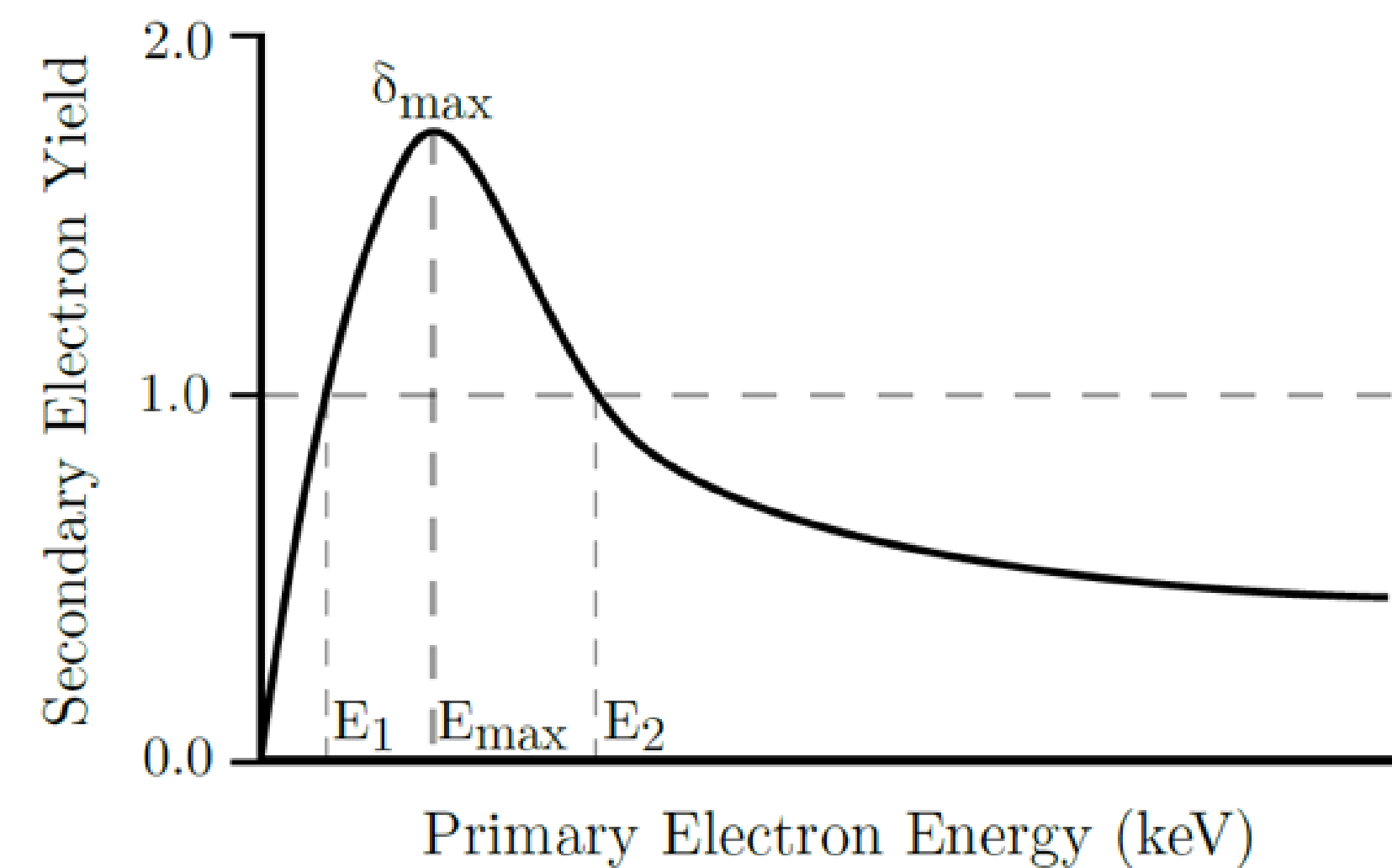
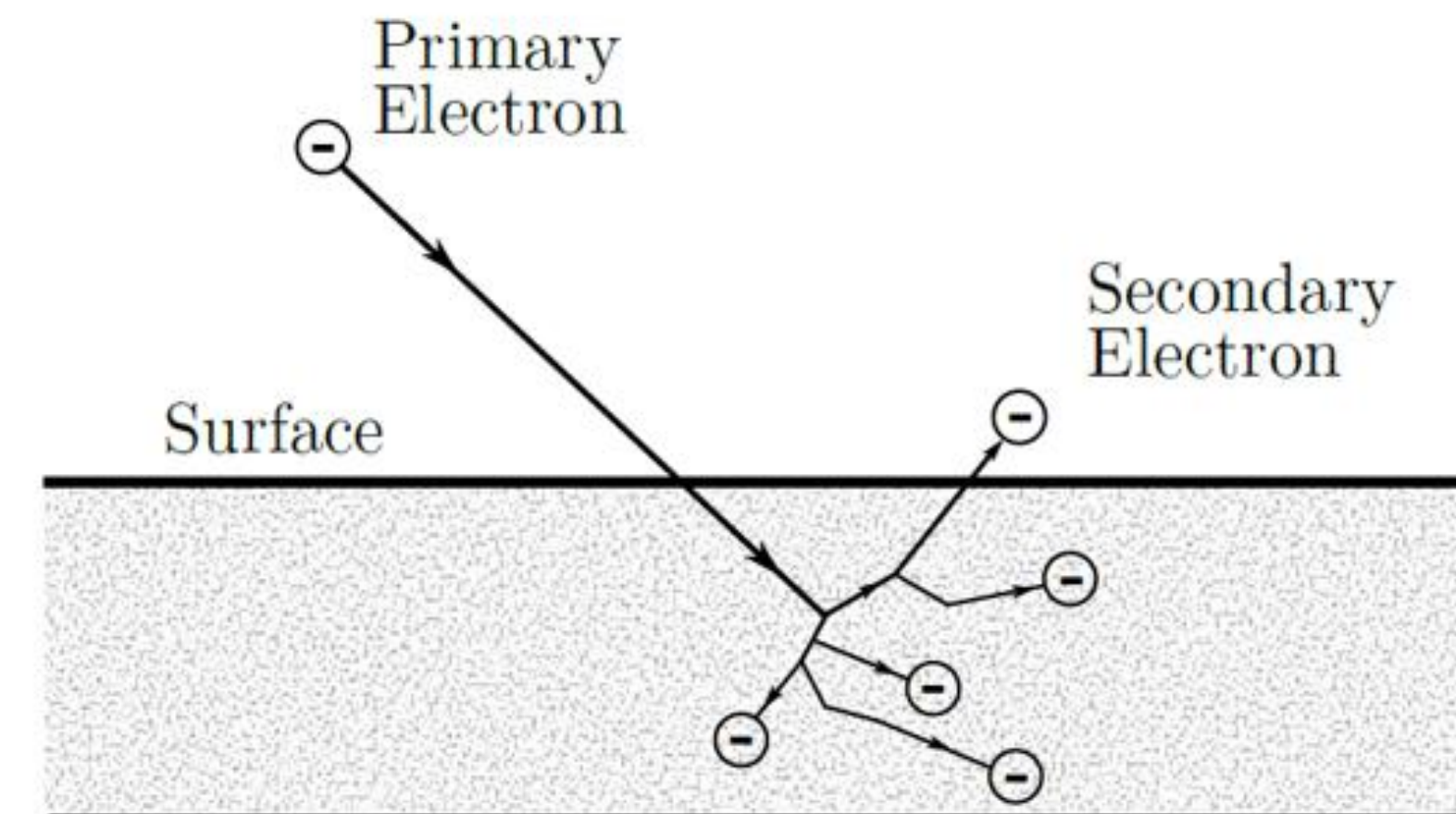
- Electrons generated on surface of target object
  - Secondaries from an active electron beam
  - Photoelectrons from sunlight
- Accelerated toward servicing craft which is at high positive potential
- Arrive with energies equal to potential difference between craft plus small initial energy
- Electron energies can be easily measured



# Secondary and Photoelectrons

**Key fact: secondary and photoelectrons emitted from surface with very low energies**

Backscattered electrons carry no information about the target potential



# Method

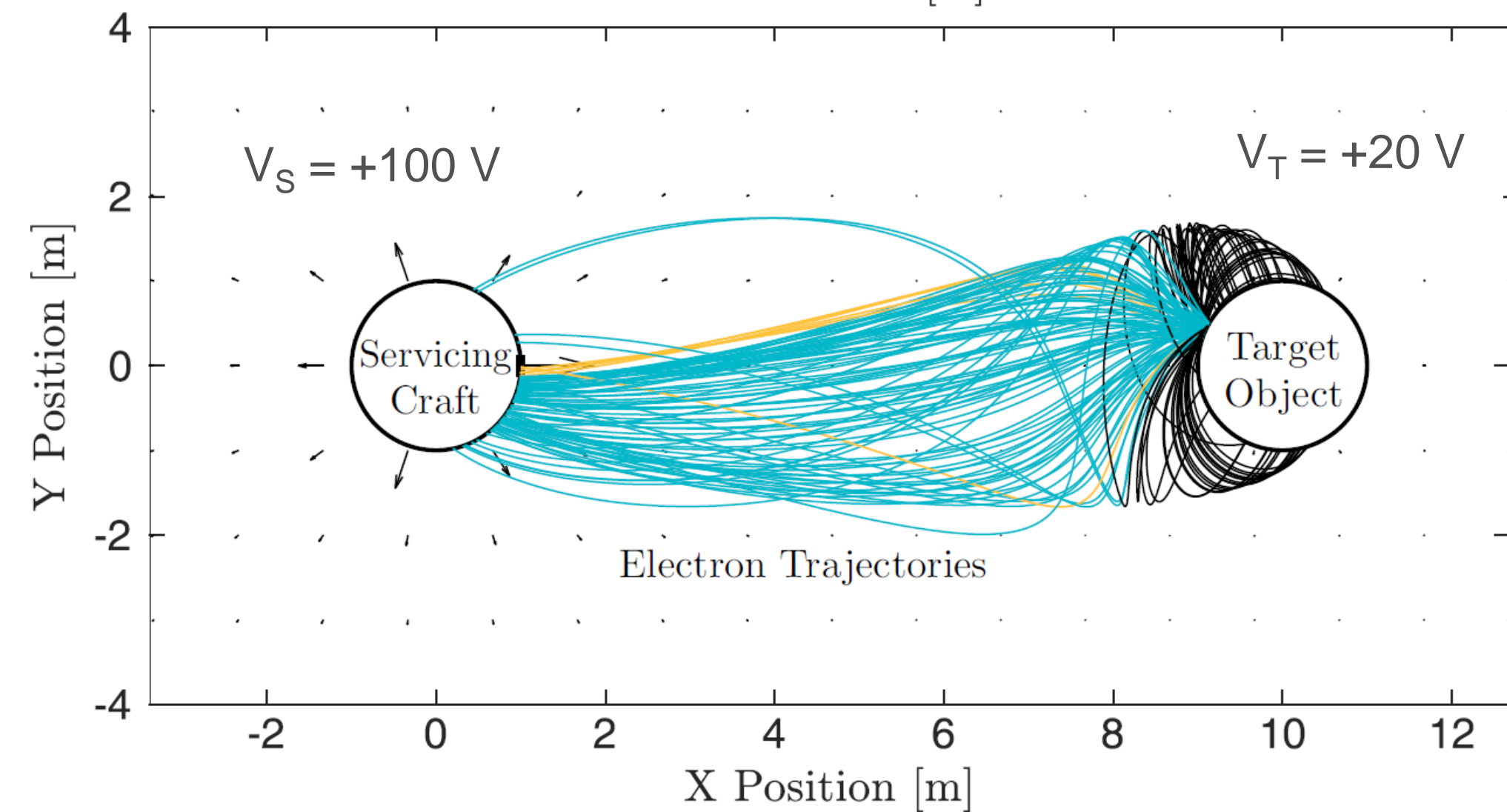
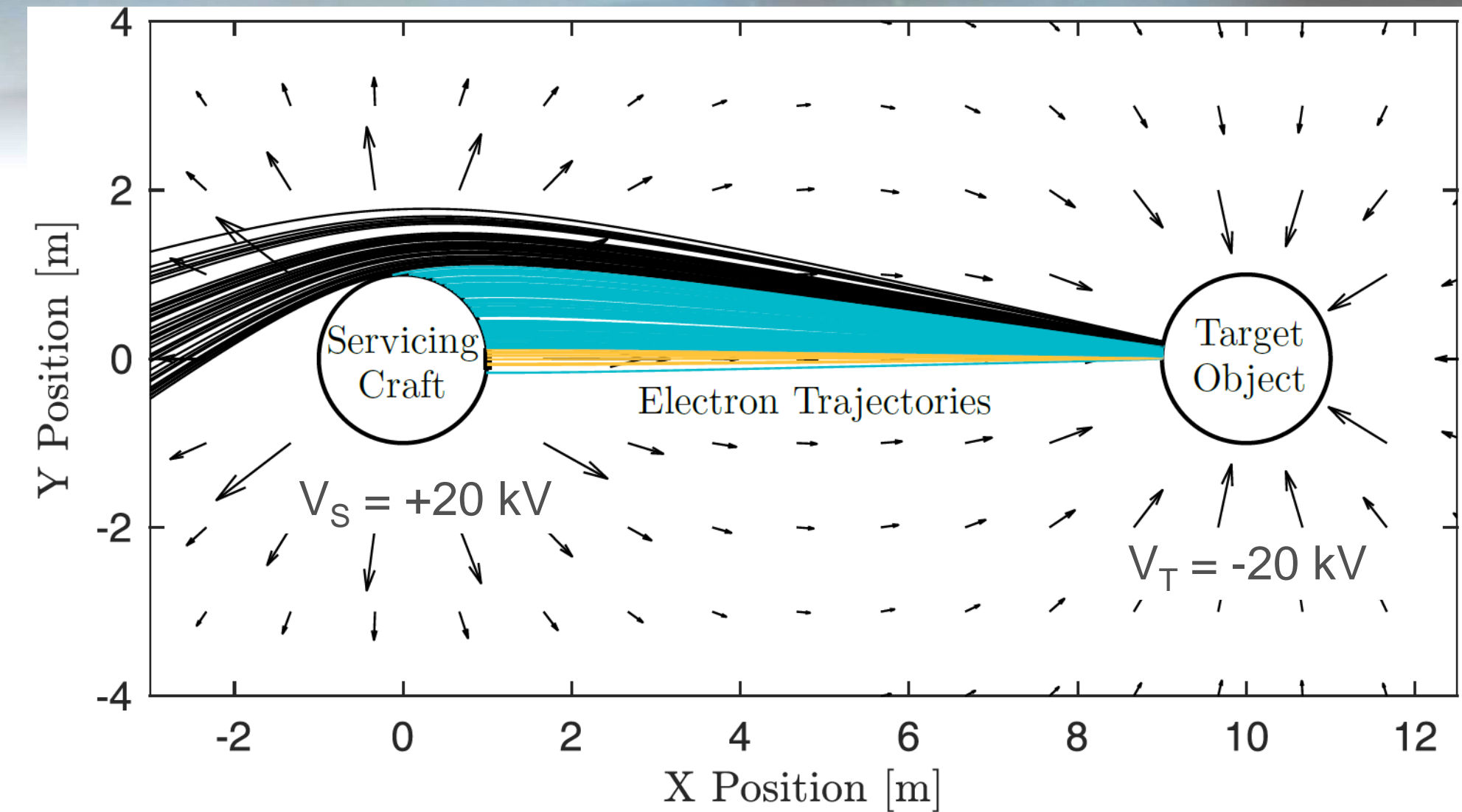


**Goal:** Investigate accuracy of electron sensing method and determine effect of relative geometries

**Approach:** Measure potential of target plate in vacuum for range of voltages and angles

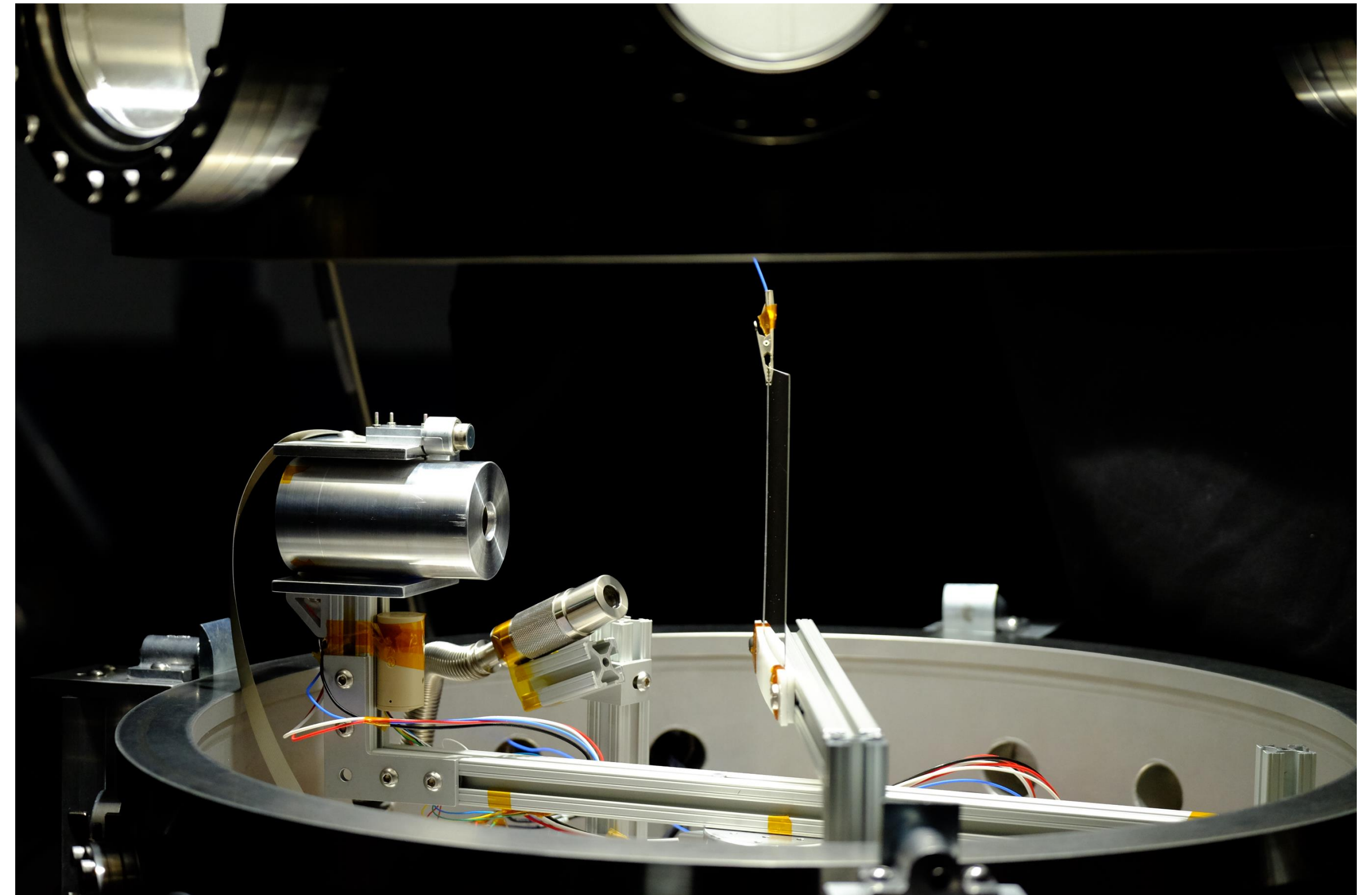
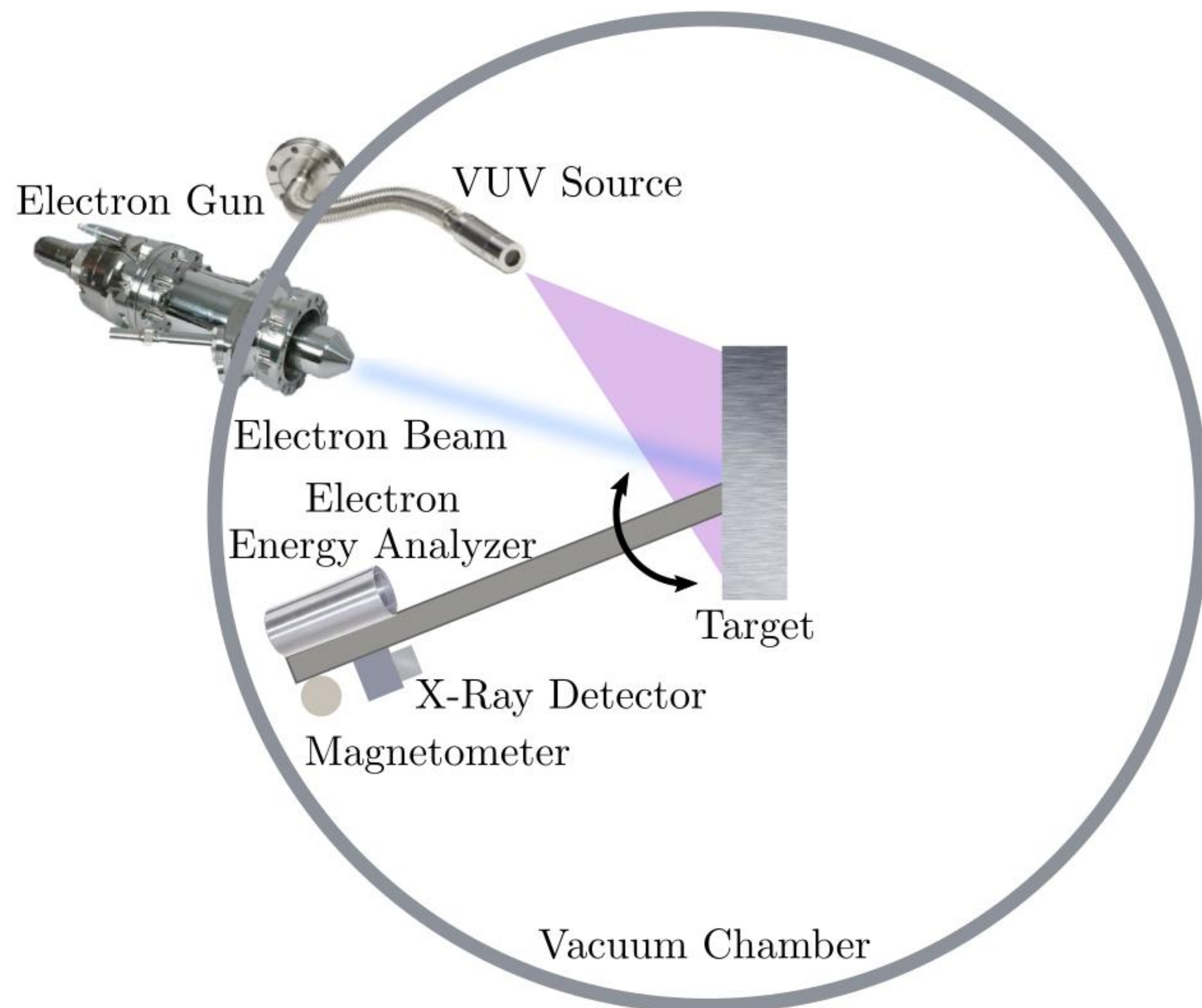
Improvements from previous work:

- Ability to test in 100-1000s V range + rotational stage
- Simulations extended to 3D
- Simulations can model electric field around arbitrary shapes using Method of Moments



# Experiment Setup

- Gridded Faraday cup used to measure energy distribution of electrons
- Obtained measurements of secondary and photo electrons from charged plate (100s of volts to kilovolts)
- Copper, Aluminum, and Inconel samples tested



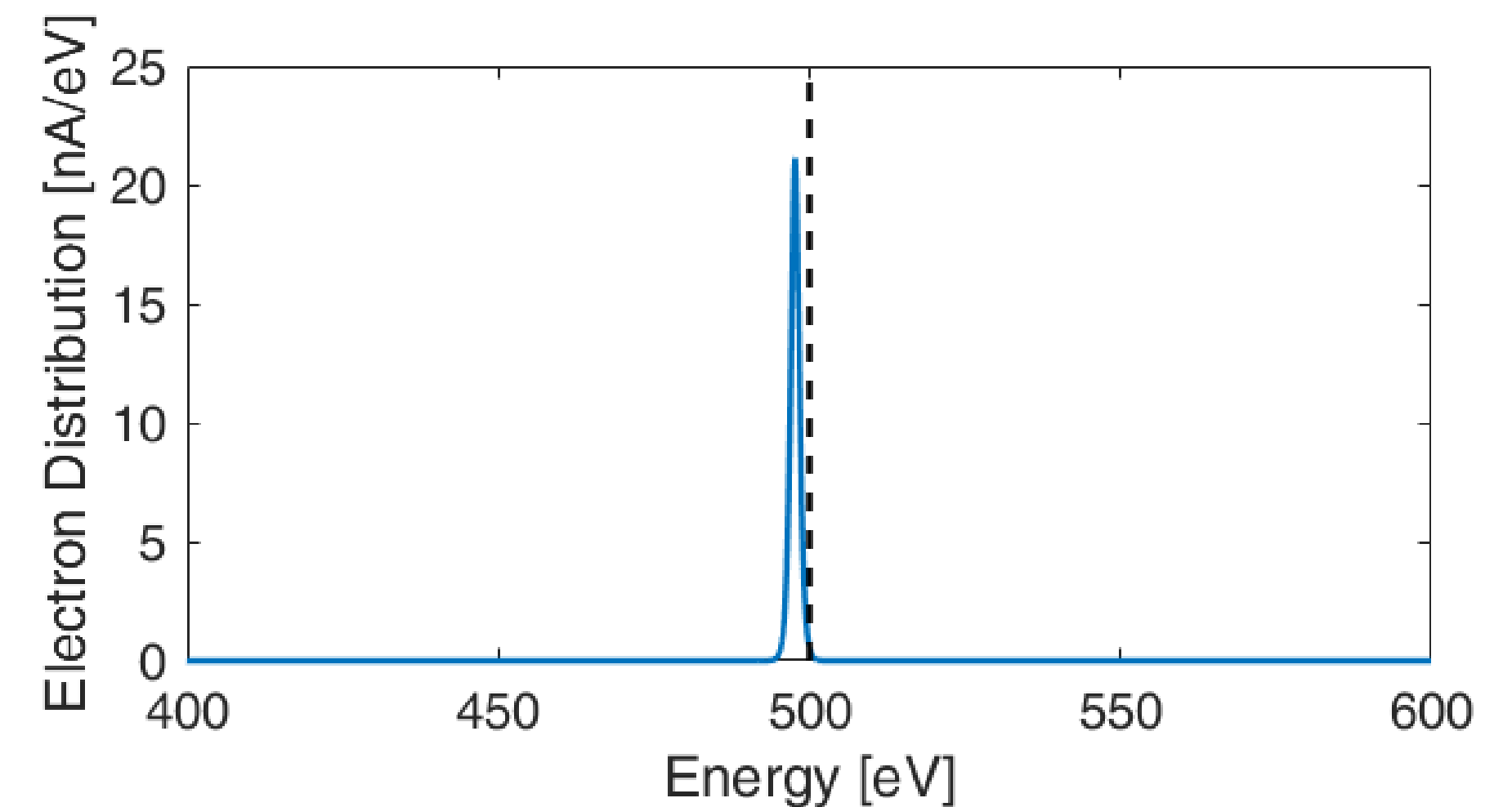
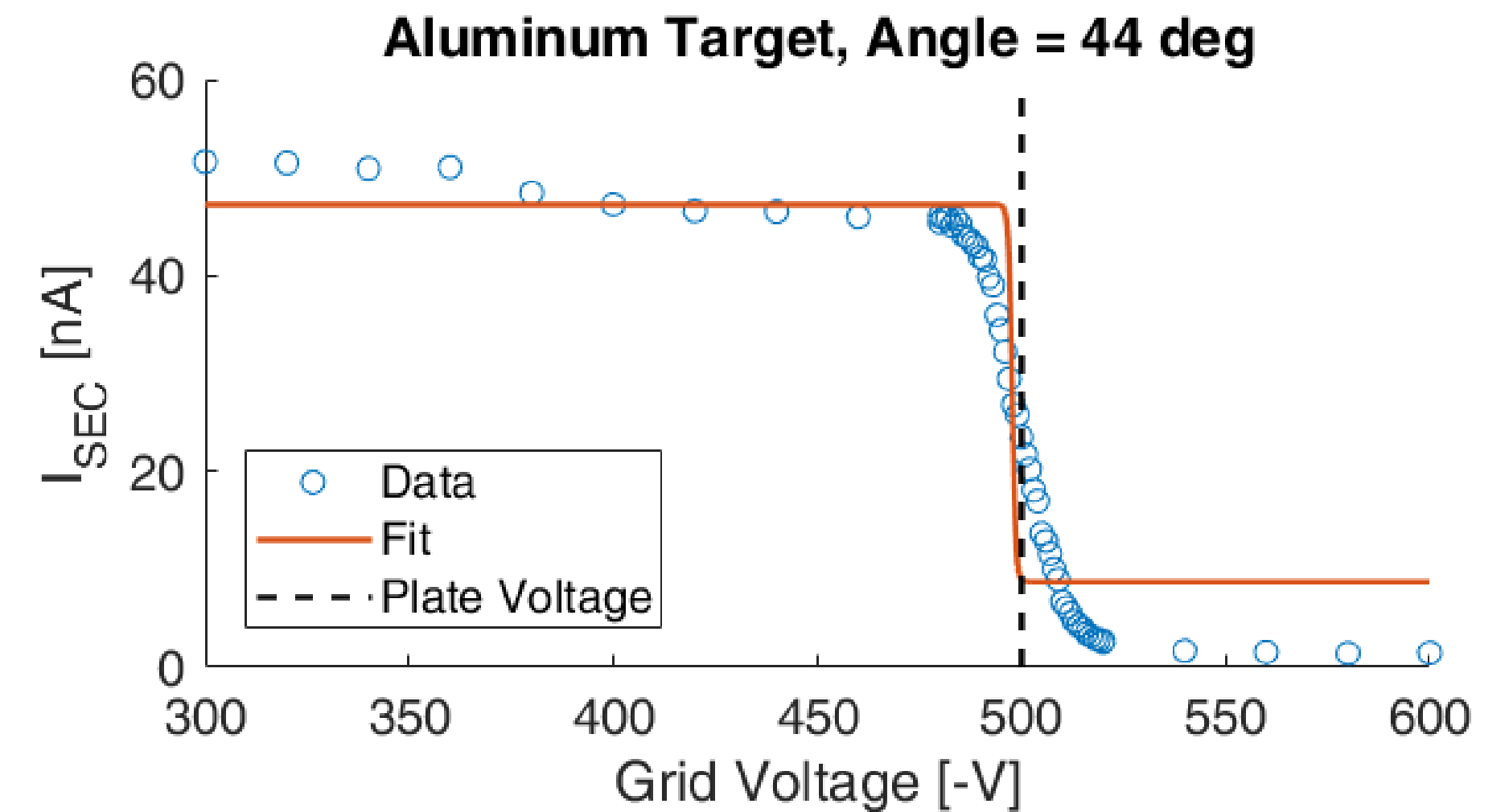
# Experiment Results



- Smooth step-function fit to raw data using nonlinear regression
- a, b, c, and d are fitting parameters
- I is the electron current and Vg is the grid voltage
- Electron energy distribution found by taking derivative
- Nonlinear fit requires decent initial guess

$$I = a - b \tanh(cV_g + d)$$

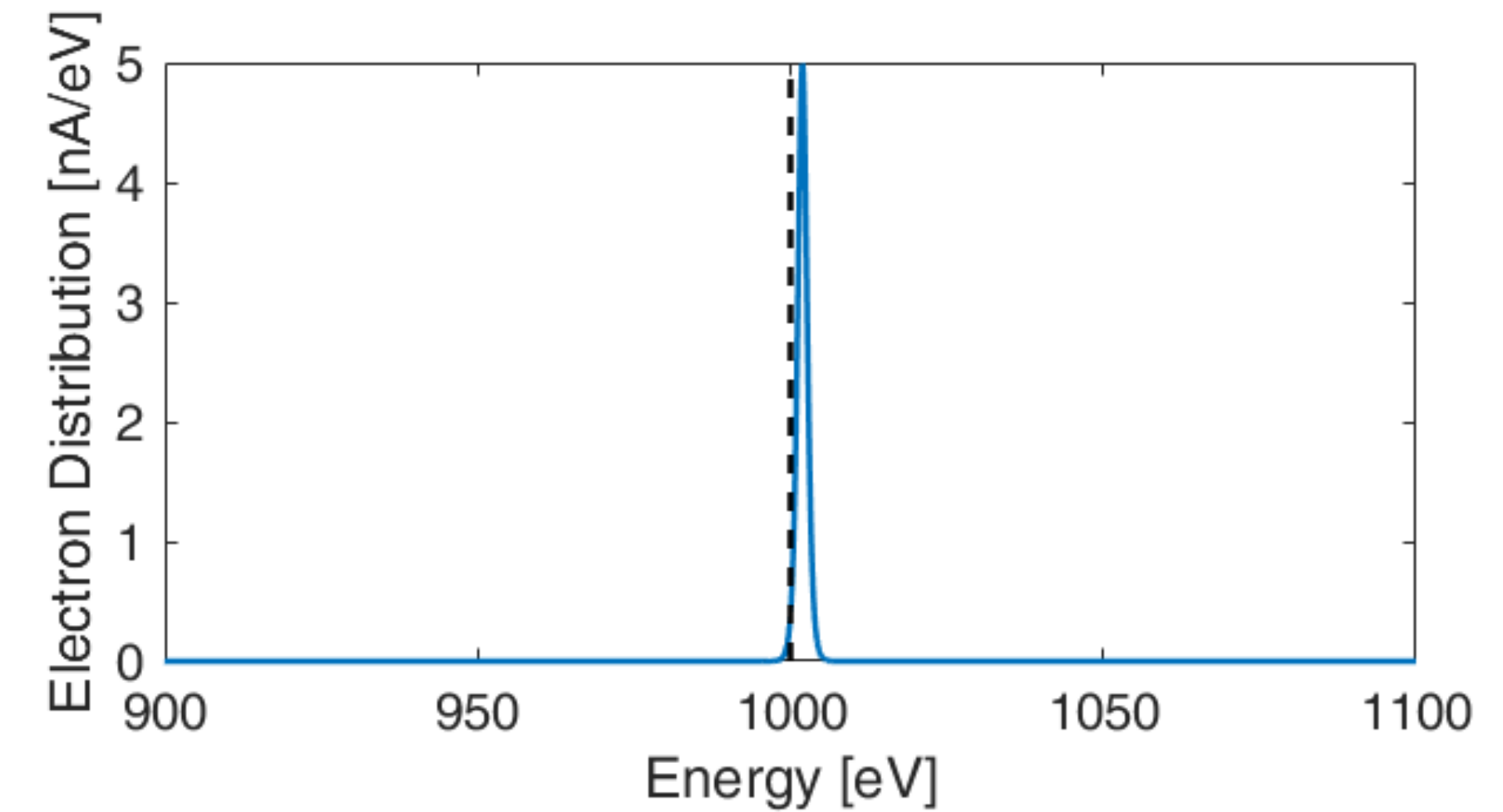
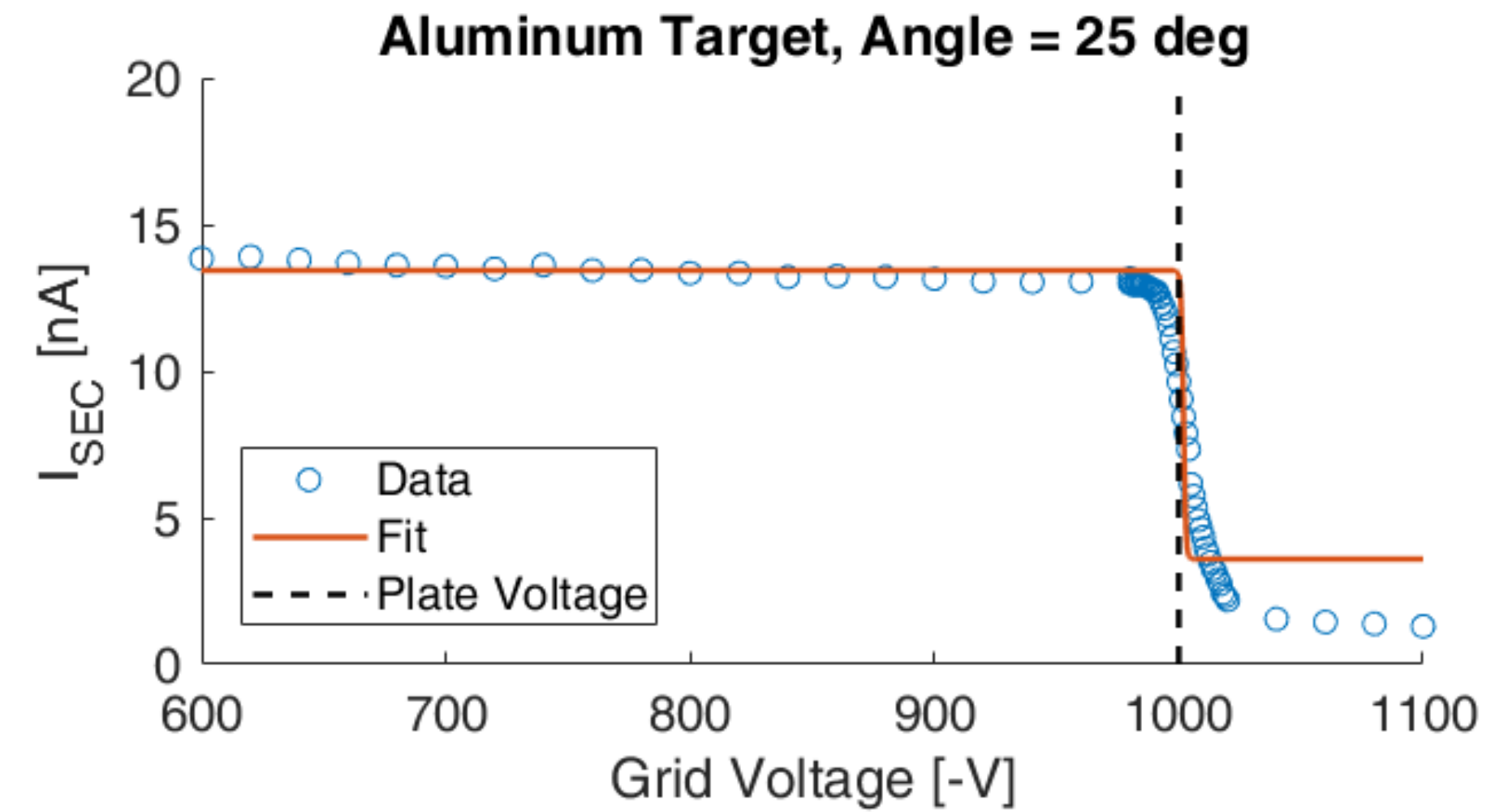
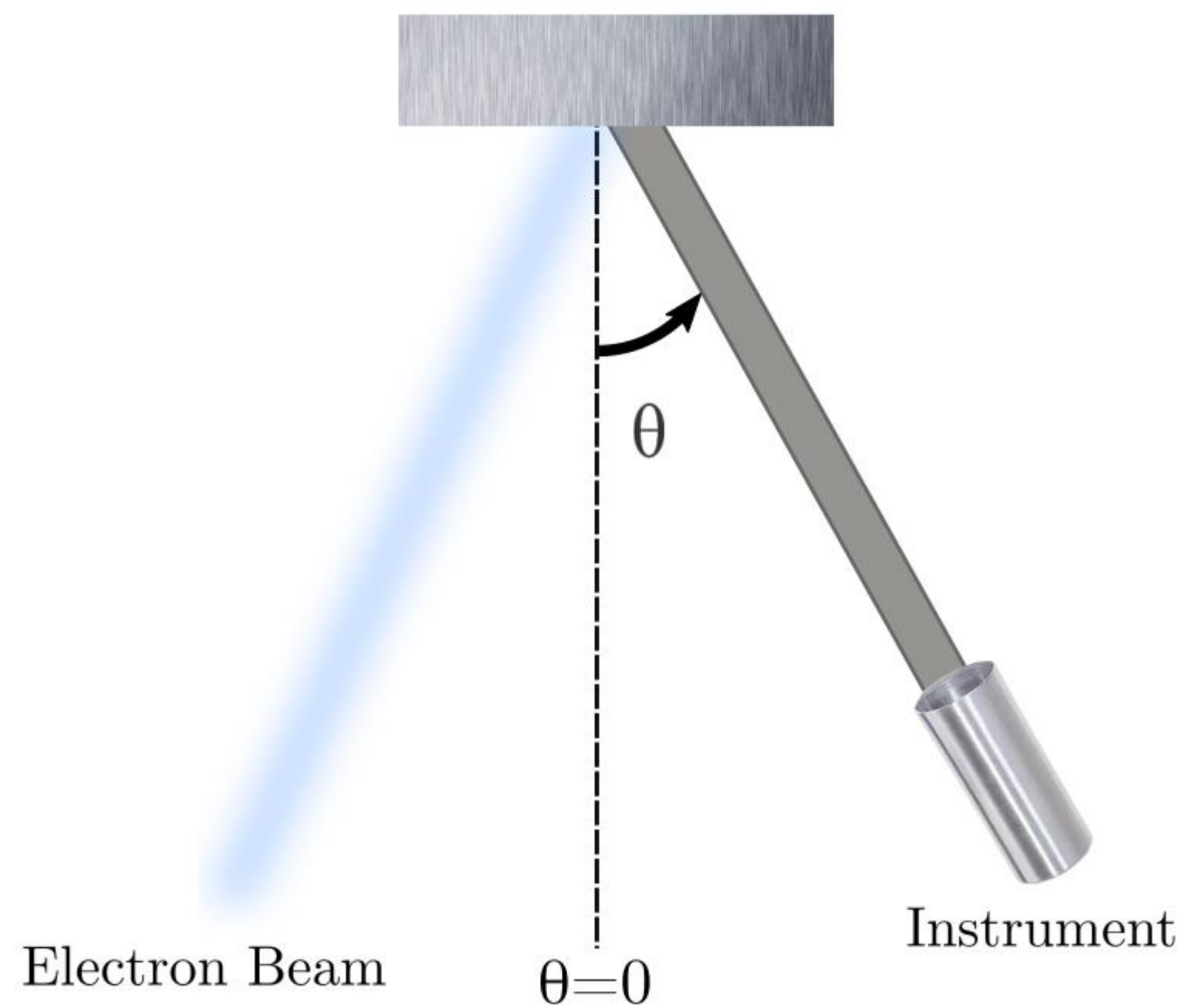
$$-\frac{dI}{dV_g} = bc (1 - \tanh^2(cV_g + d))$$



# Experiment Results – Electron Beam



Rotational stage allows data collection over 110°, from -20° to +90°

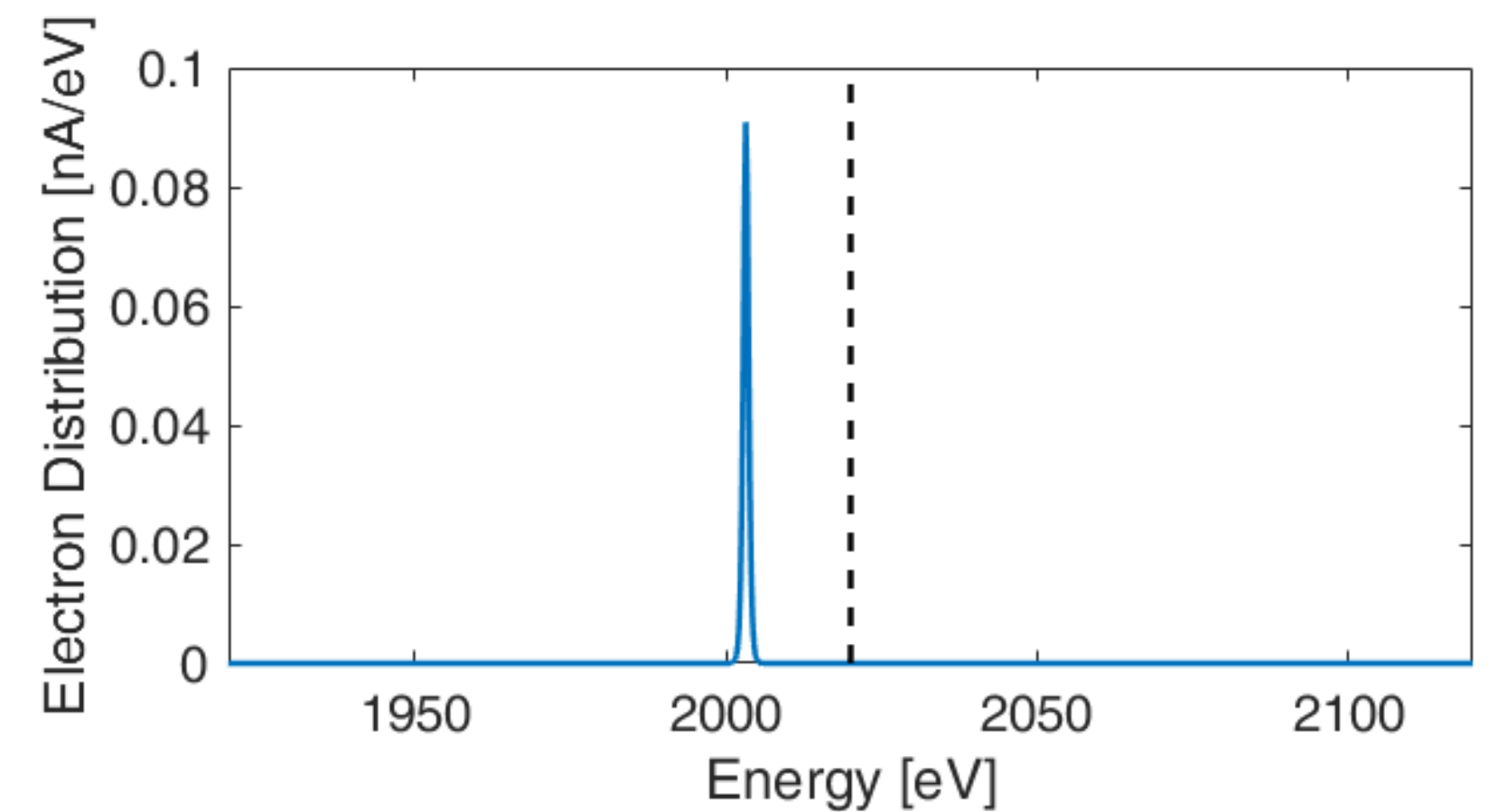
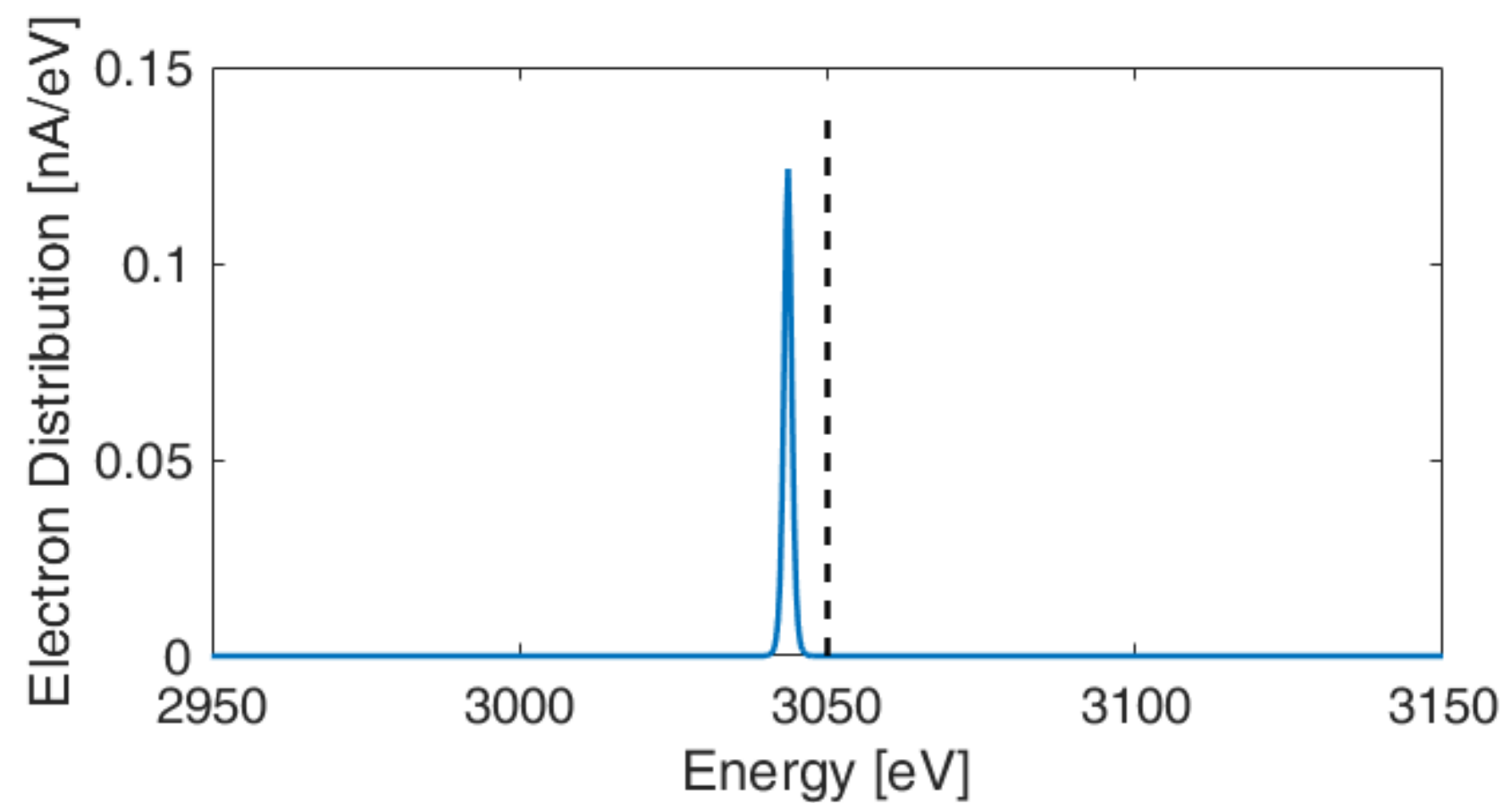
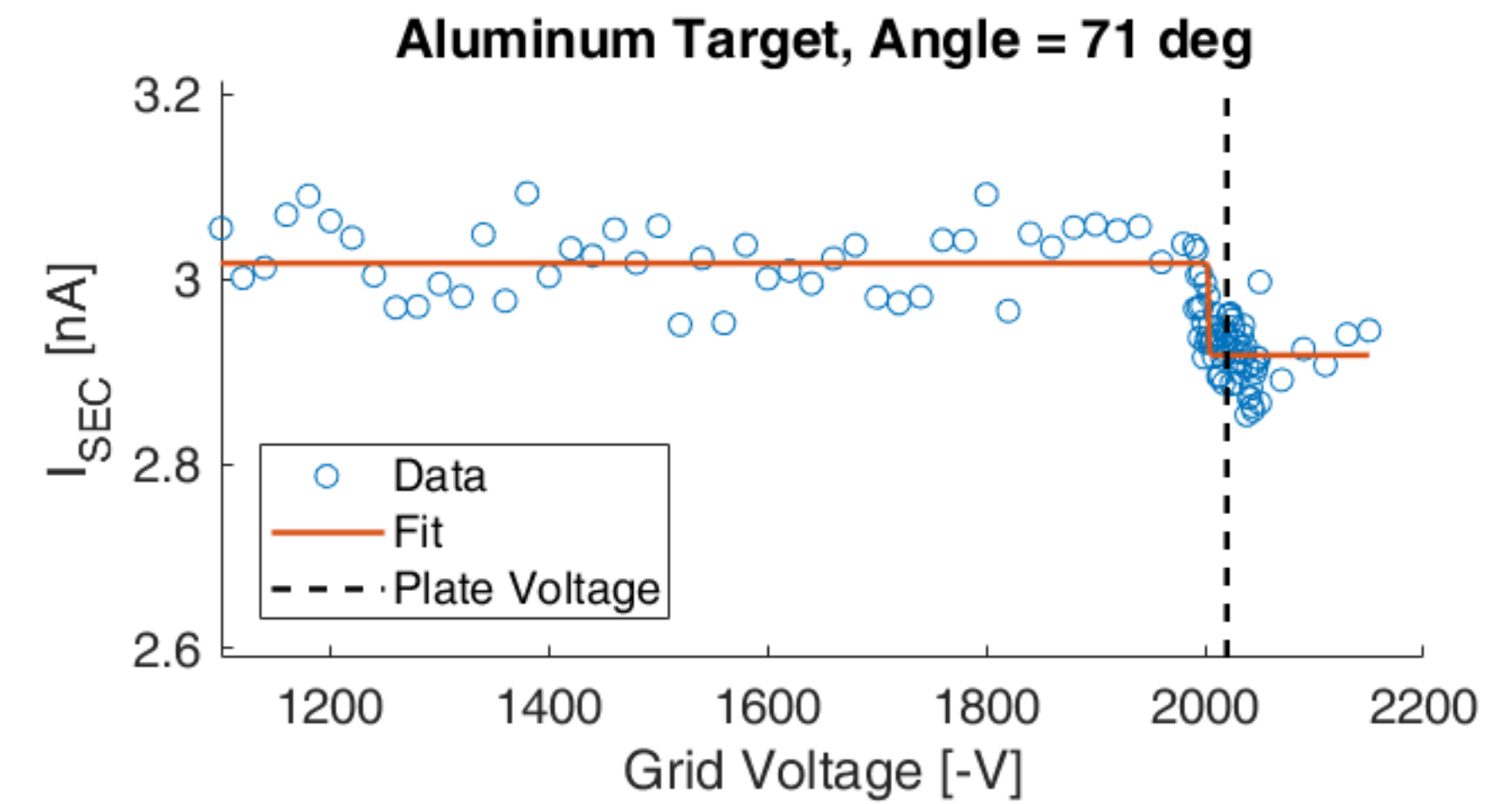
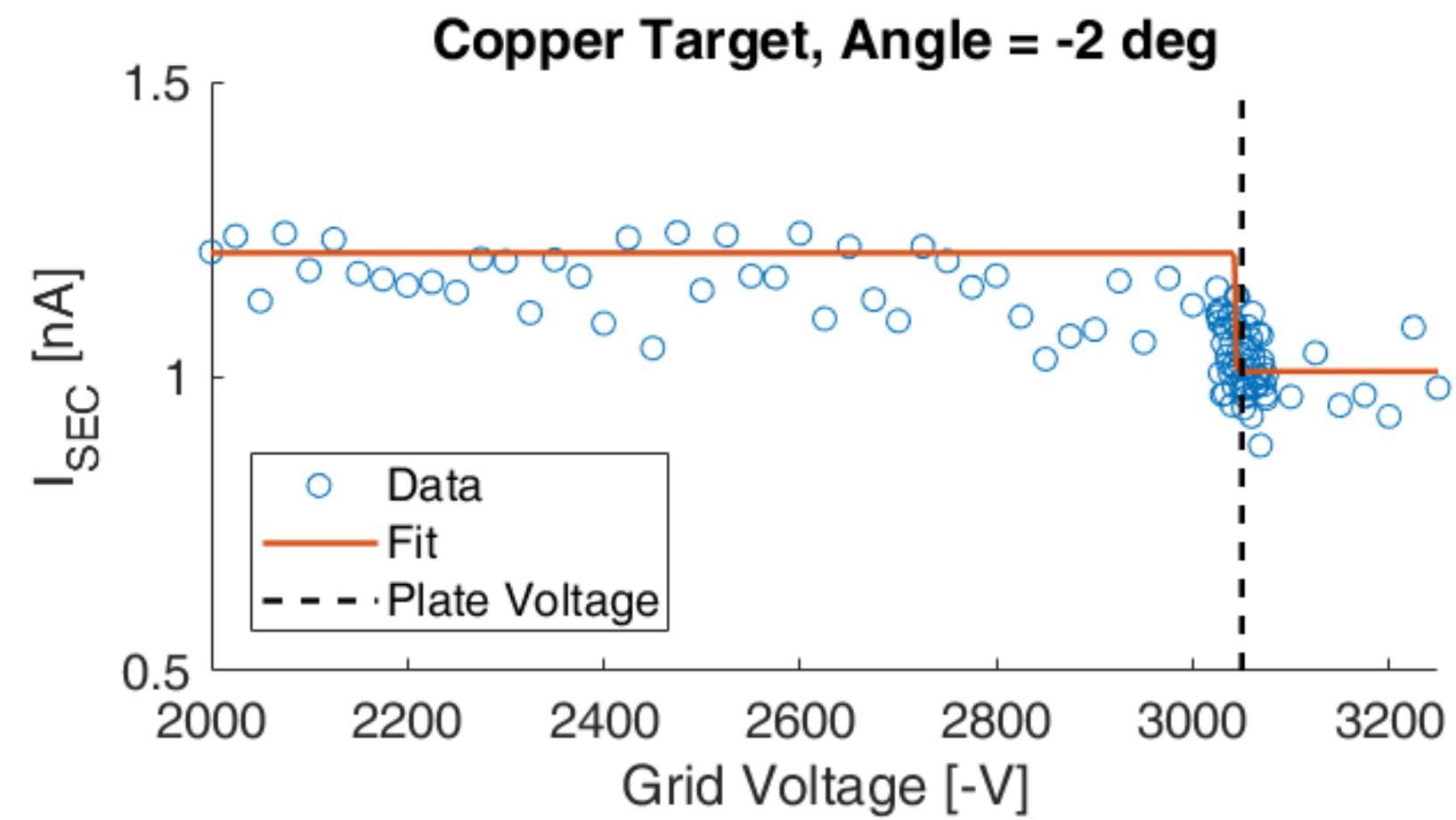




# Experiment Results – Electron Beam



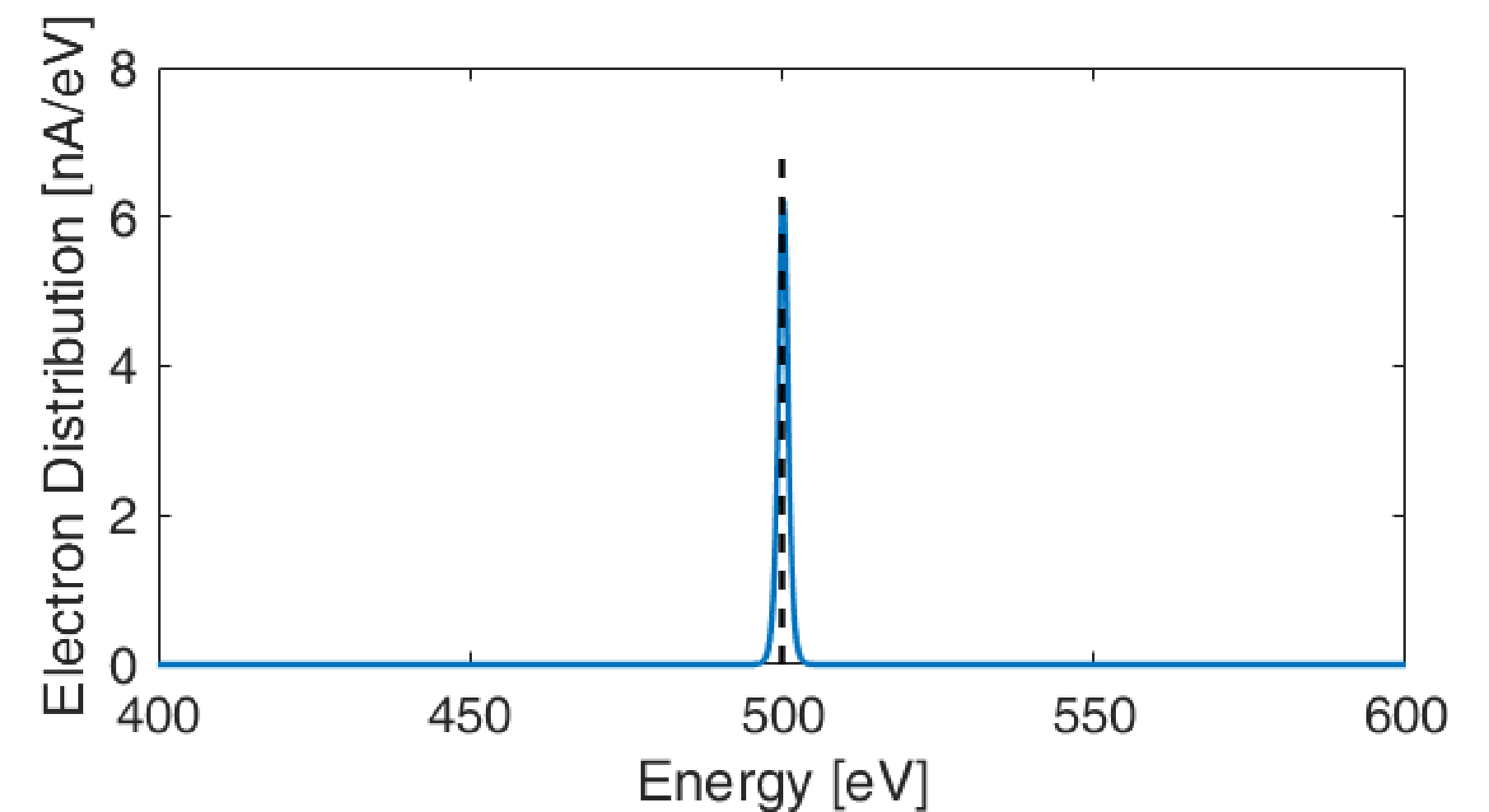
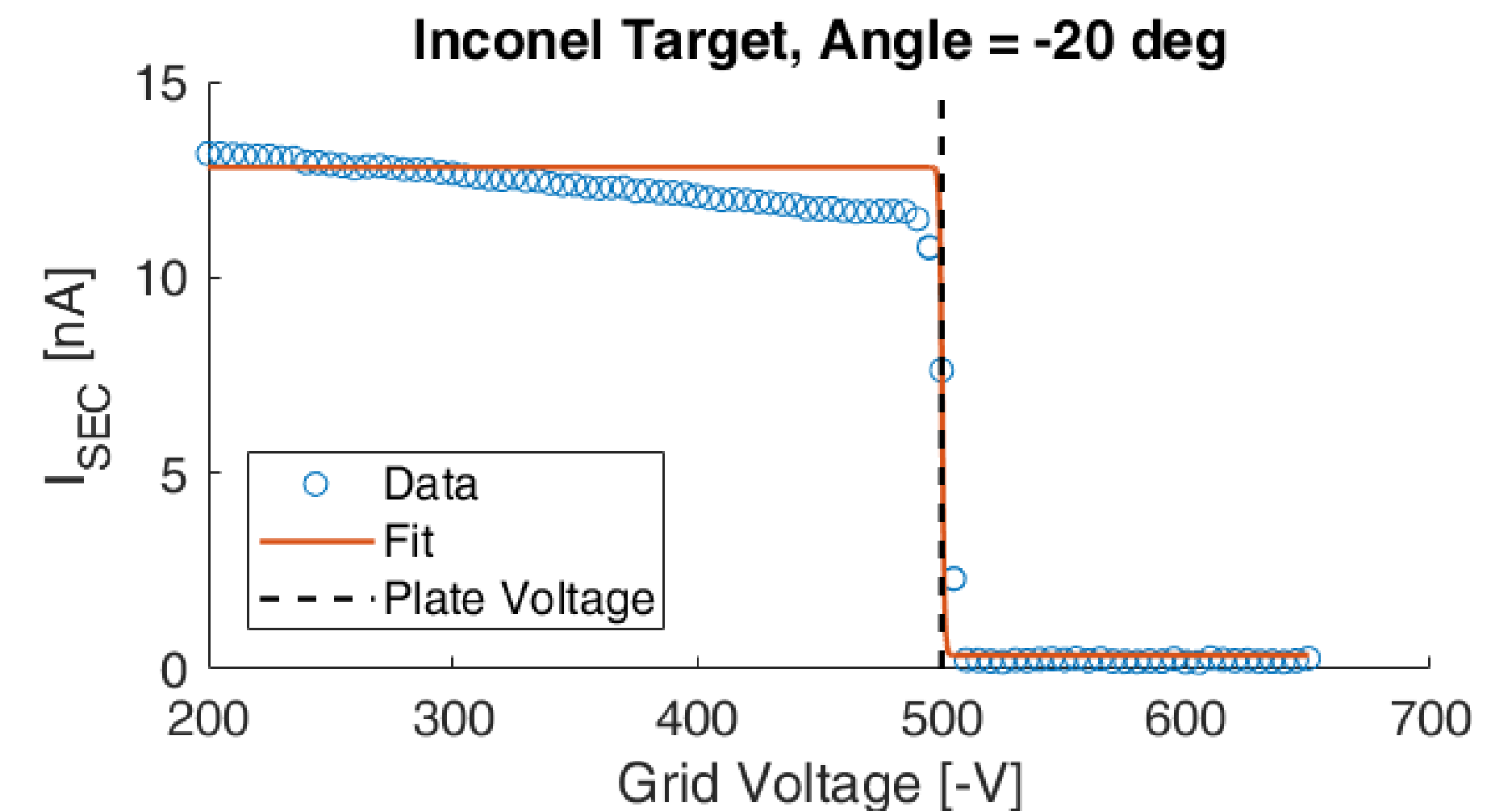
- Electron sensing method is extremely accurate
- Wide range of plate voltages
- Even for low signals and large angles



# Experiment Results – Photoelectrons



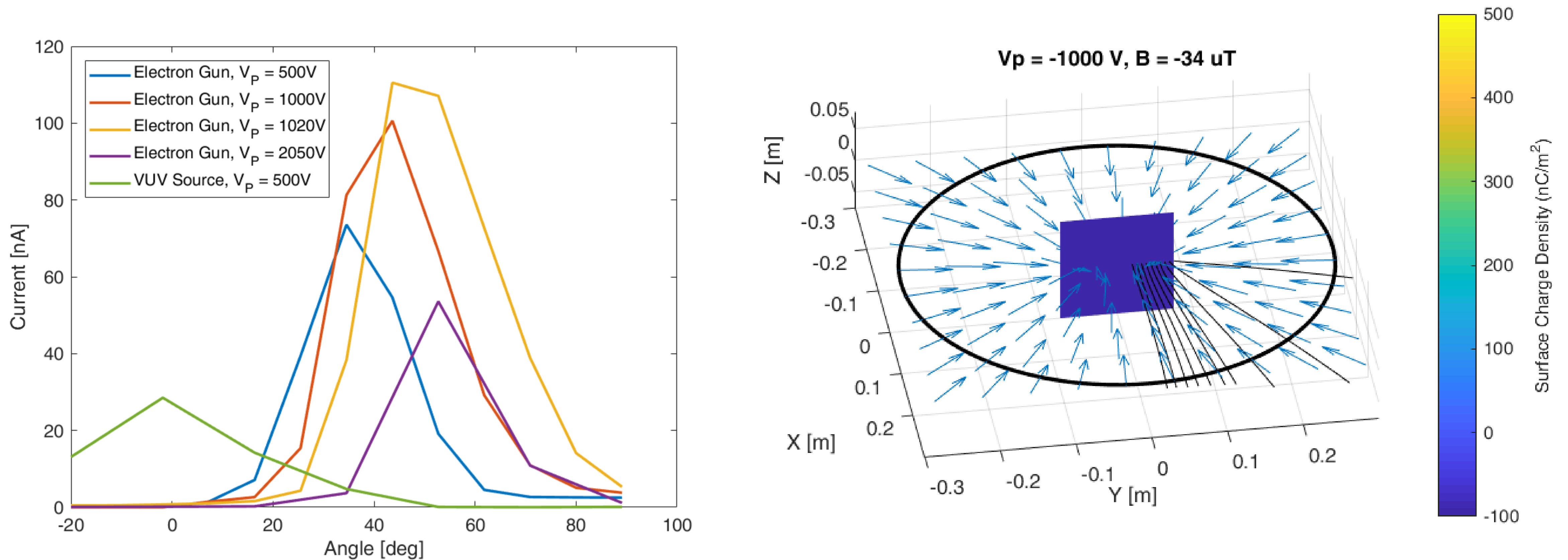
- Photoelectron current from VUV light also gives excellent touchless measurement of plate potential
- All materials tested give consistent results
  - Current experiments: Copper, Aluminum, Inconel
  - Previous experiments: Aluminized mylar, ITO



# Experiment Results – Geometry



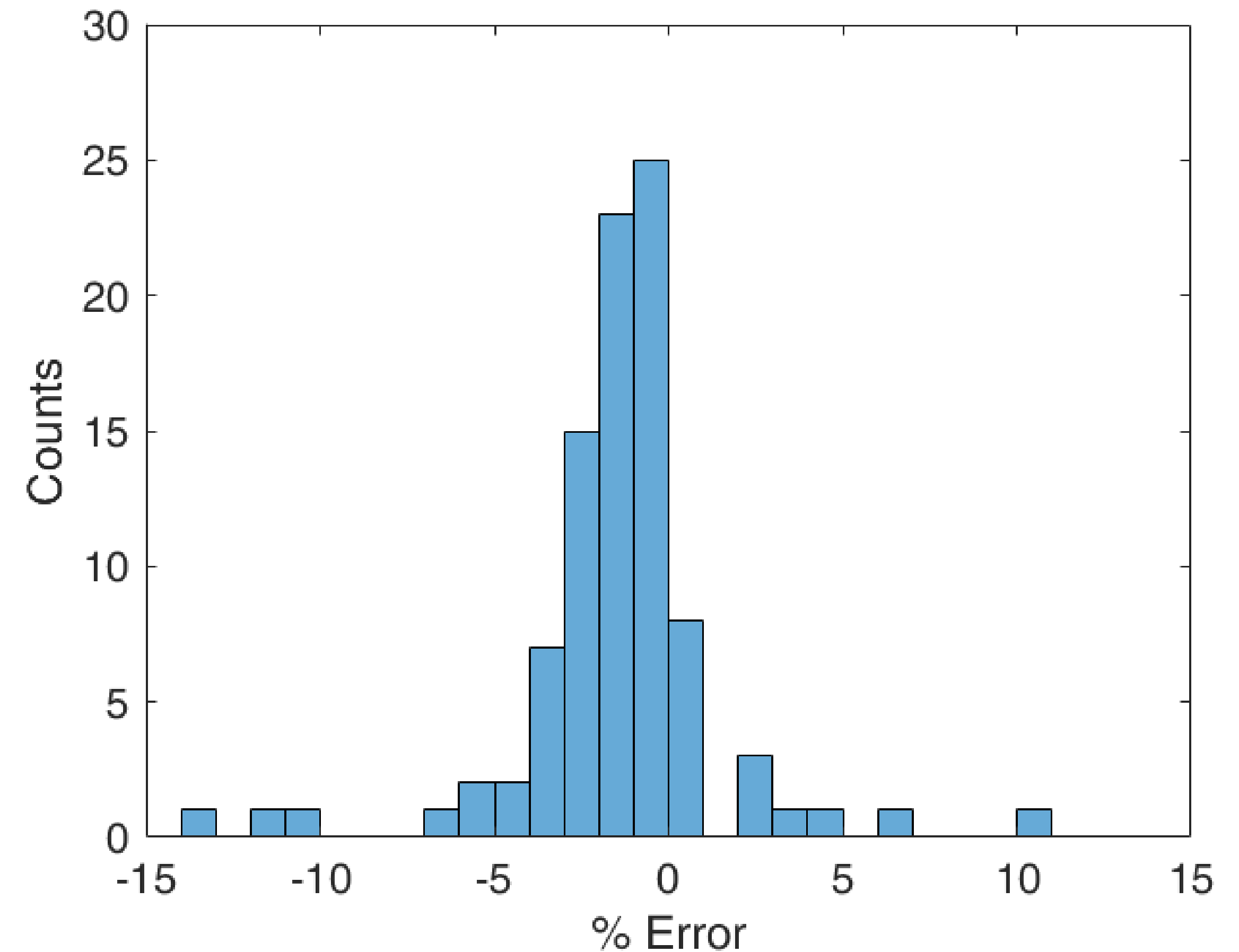
- Largest current for electron gun tests actually occurs at an angle of 35-50° off normal
- Photoelectron tests centered about normal



# Experiment Results – Error



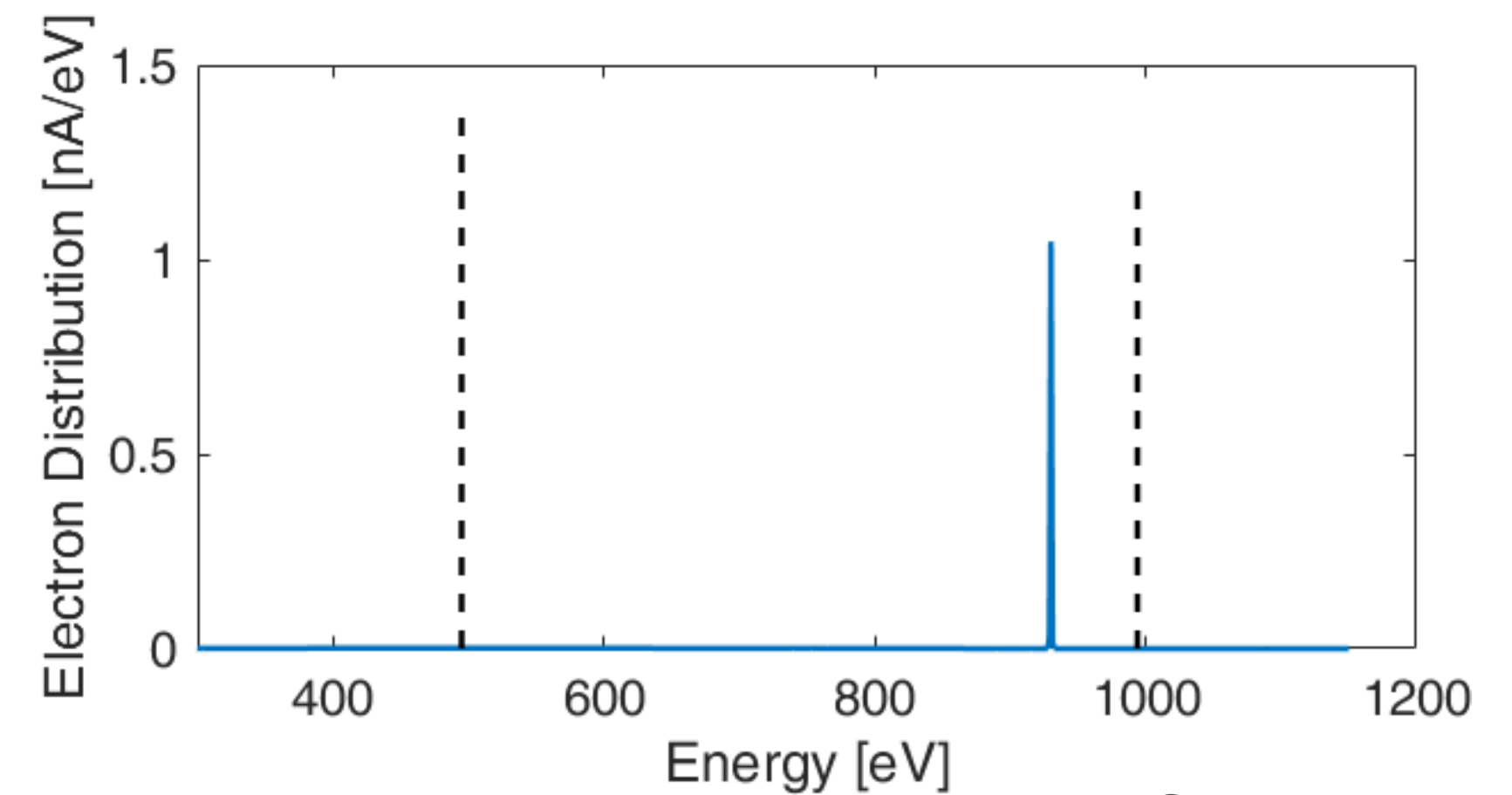
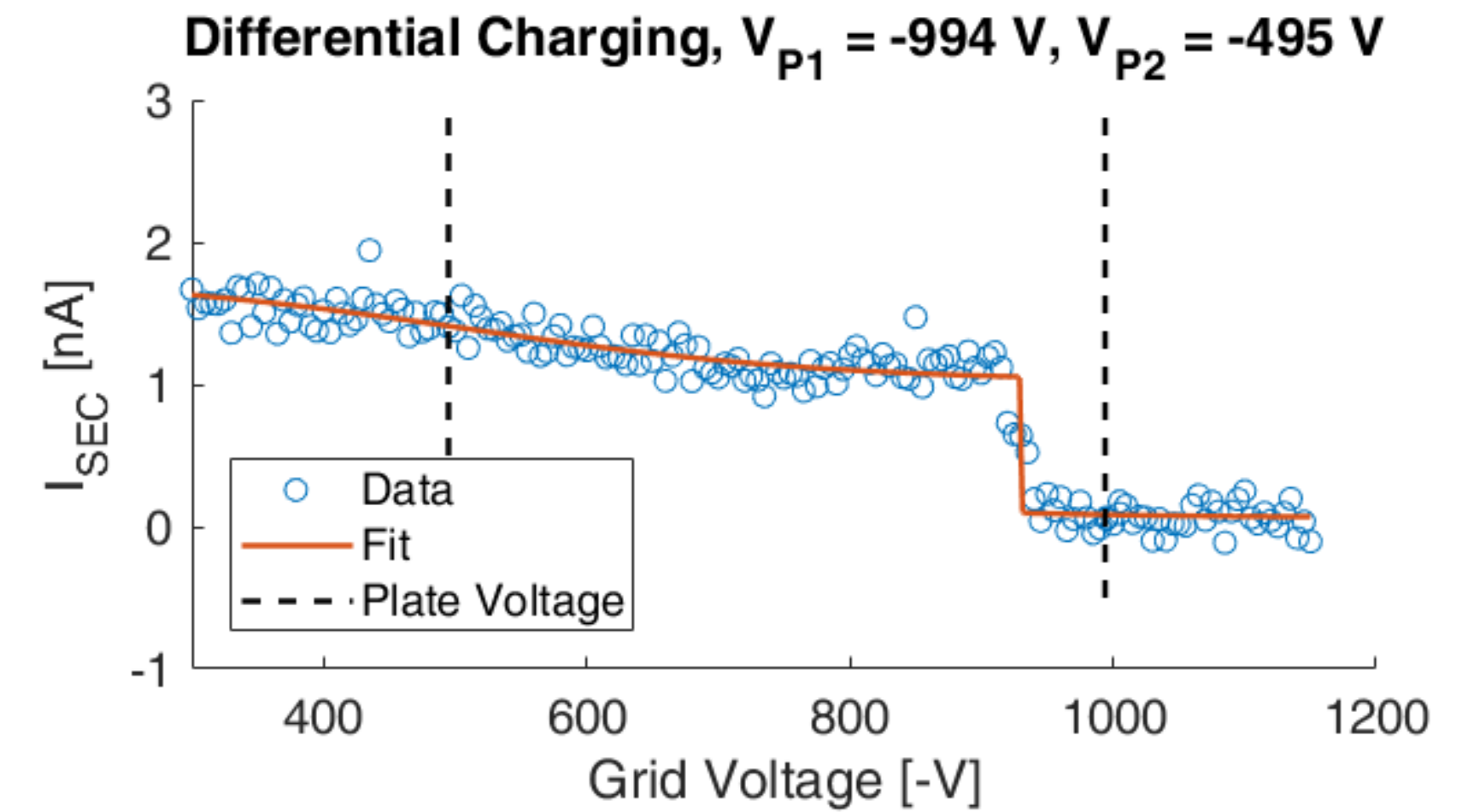
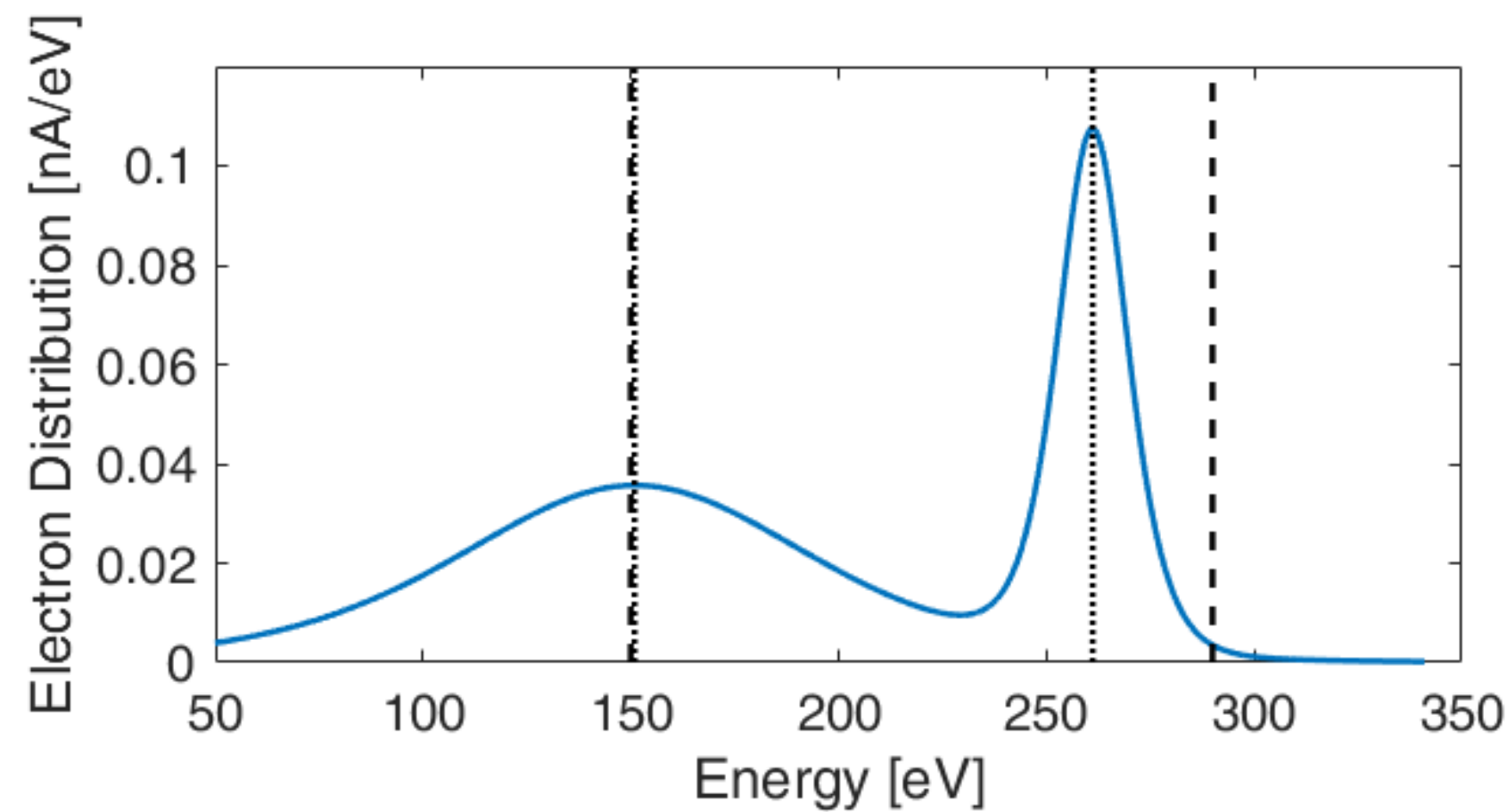
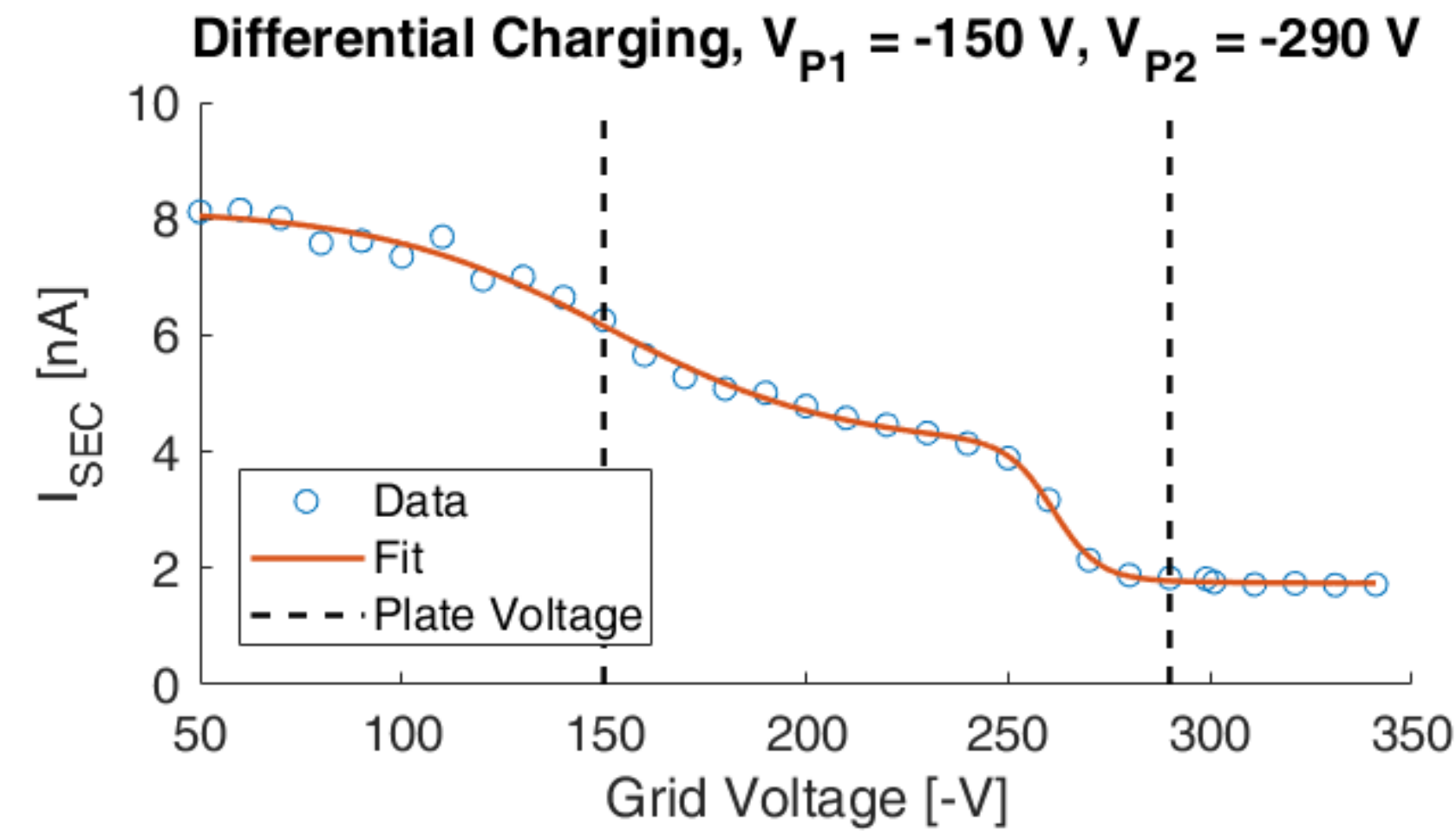
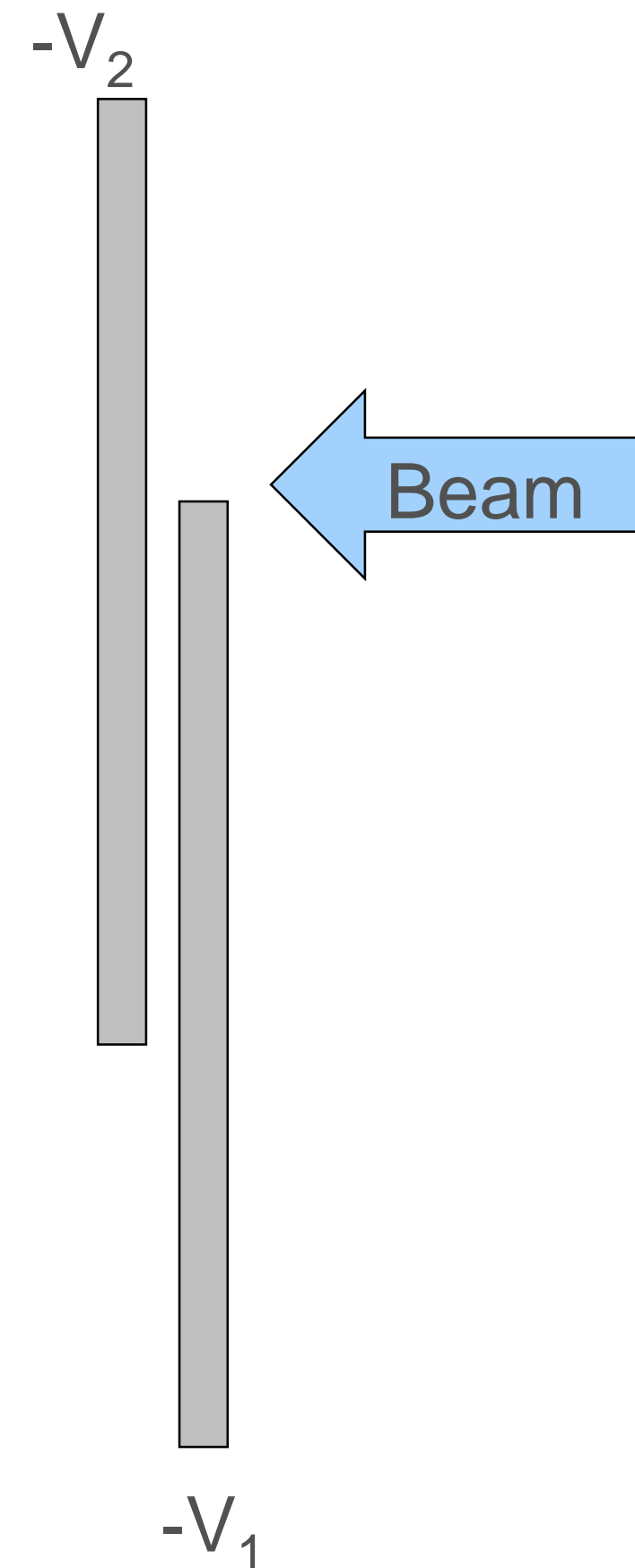
- Excluded cases where  $-dI/dV < 0.1 \text{ nA/eV}$
- Average error across all materials/angles/voltages =  $-0.257\%$
- Mode at  $\sim 7\%$  is from single test with  $V_p = -130\text{V}$
- Reason to suspect accuracy of HVPS at low voltages
- Average error is now =  $-1.42\%$



# Experiment Results – Differential Charging



- Differential charging results always find peak at larger voltage, even when voltage on plates is switched
- Electric field at edge of plate 1 drives electrons straight up?



# Comparison of Methods



Electron Sensing	X-Ray Sensing
Photoelectrons provide passive sensing option	Requires electron beam (?)
Servicing craft must be positive	Signal independent of servicing craft potential
Material identification not straightforward (auger peaks?)	Characteristic peaks allow identification of material
Demonstrated use sensing lunar potential surface	Demonstrated use for asteroid surface characterization
Prolific on-orbit	Less common in Earth orbit

- Future missions could incorporate both methods for a robust potential sensing instrument
- Future work will compare the methods in more detail and develop data fusion algorithms

## Conclusion:

### Touchless potential sensing works

- Over a large range of spacecraft potentials
- With both secondaries and photoelectrons
- For a variety of common spacecraft materials
- Over a wide range of relative attitudes
- With readily-available instrumentation
- Accurate to within a few % error

## Future work:

- Conduct experiments and simulations with realistic spacecraft shapes and differential charging
- Develop filter to determine electron distribution without prior knowledge
- Data fusion from multiple sensors
- Implement system on experimental testbed with tumbling model spacecraft

# Acknowledgements and Contact Info



## Acknowledgements:

ASEC Student Travel Award

Dalton Turpen

Jordan Maxwell

Will Starck

## Contact Info:

Miles Bengtson

University of Colorado Boulder

[mibe4496@colorado.edu](mailto:mibe4496@colorado.edu)

704.615.3523